

### ● General Description

The K50N06 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

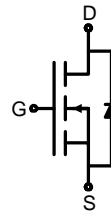
### ● Features

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

### ● Application

- MB/VGA Vcore
- SMPS 2<sup>nd</sup> Synchronous Rectifier
- POL application
- BLDC Motor driver

### ● Product Summary



$V_{DS} = 60V$      $I_D = 50A$   
 $R_{DS(ON)}(10V \text{ typ}) = 14m\Omega$   
 $R_{DS(ON)}(4.5V \text{ typ}) = 18m\Omega$



**TO-252**

### ● Absolute Maximum Ratings (T<sub>C</sub> = 25°C)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	60	V
Gate-Source Voltage	$V_{GS}$	20	V
Continuous Drain Current	$I_{D@TC=25^\circ C}$	50	A
	$I_{D@TC=75^\circ C}$	35	A
	$I_{D@TC=100^\circ C}$	30	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	104	A
Total Power Dissipation(TC=25°C)	$P_D@TC=25^\circ C$	70	W
Total Power Dissipation(TA=25°C)	$P_D@TA=25^\circ C$	2.8	W
Operating Junction Temperature	$T_J$	-55 to 150	°C
Storage Temperature	$T_{STG}$	-55 to 150	°C
Avalanche Current	$I_{AS} I_{AR}$	40	A

#### ●Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$	-	-	2.8	$^{\circ}C/W$
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	55	$^{\circ}C/W$
Soldering temperature, wavesoldering for 10s	$T_{sold}$	-	-	265	$^{\circ}C$

#### ●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	1.0	1.5	2.2	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS} = 60V, V_{GS} = 0V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 20A$		14	21	m $\Omega$
		$V_{GS} = 4.5V, I_D = 15A$		18	25	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 25V, I_D = 10A$		20		S
Source-drain voltage	$V_{SD}$	$I_S = 20A$			1.20	V

#### ●Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	$C_{iss}$	$V_{DS} = 25V$ $V_{GS} = 0V$ $f = 1MHz$	-	1000	-	pF
Output capacitance	$C_{oss}$		-	108.5	-	
Reverse transfer capacitance	$C_{rss}$		-	96.9	-	

#### ●Gate Charge characteristics( $T_a = 25^{\circ}C$ )

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	$Q_g$	$V_{DD} = 25V$ $I_D = 10A$ $V_{GS} = 10V$	-	15	-	nC
Gate - Source charge	$Q_{gs}$		-	4.5	-	
Gate - Drain charge	$Q_{gd}$		-	7.5	-	

Note: ① Pulse Test : Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$  ;

Fig.1 Power Dissipation

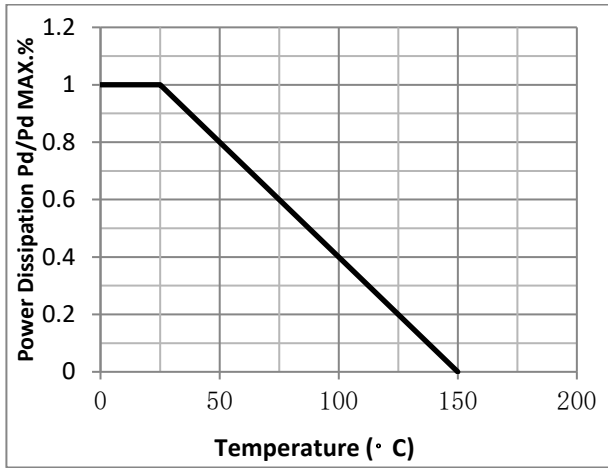


Fig.2 Typical output Characteristics

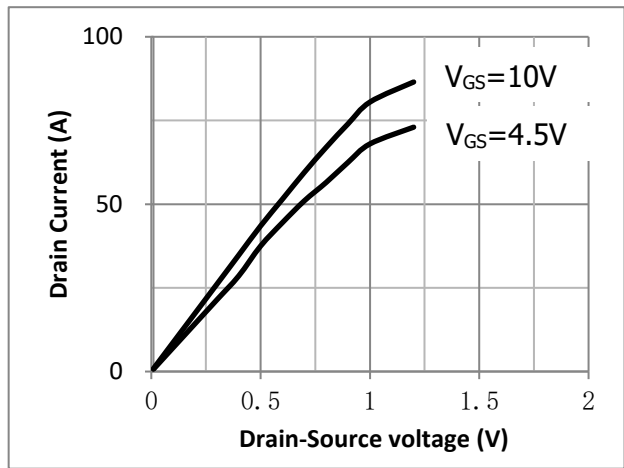


Fig.3 Threshold Voltage V.S Junction Temperature

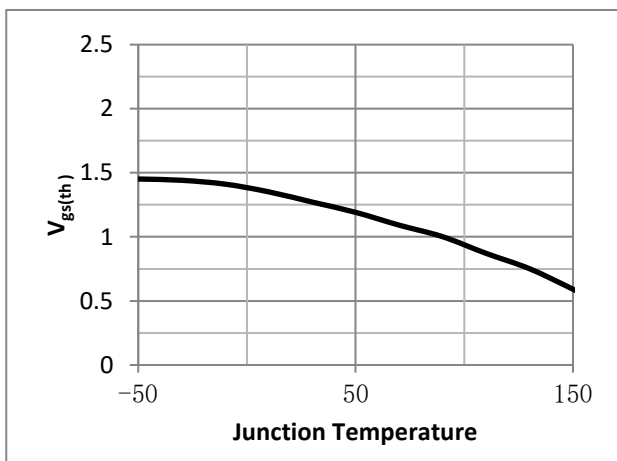


Fig.4 Resistance V.S Drain Current

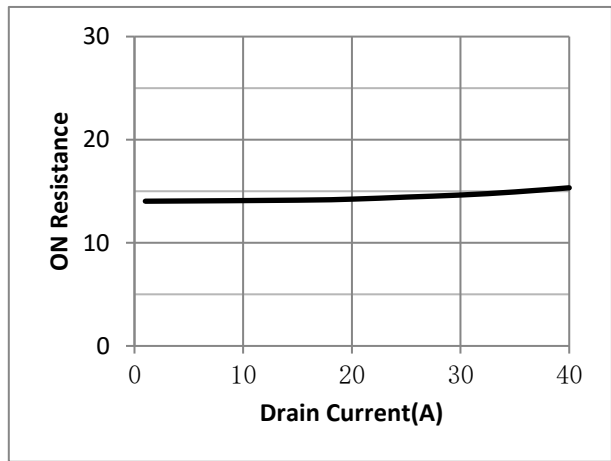


Fig.5 On-Resistance VS Gate Source Voltage

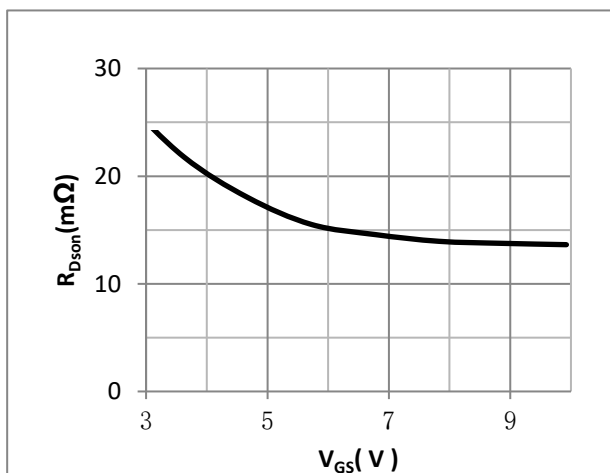


Fig.6 On-Resistance V.S Junction Temperature

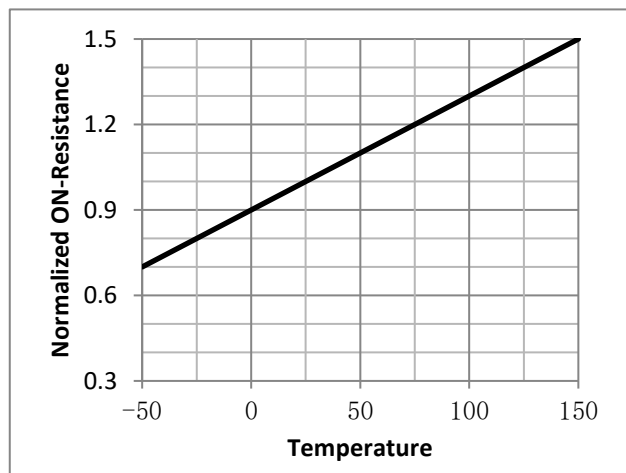


Fig.7 Switching Time Measurement Circuit

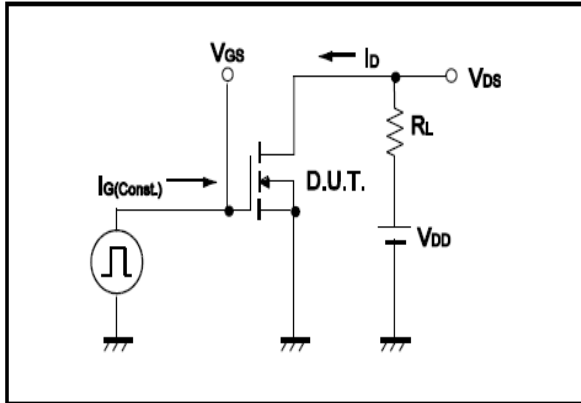


Fig.8 Gate Charge Waveform

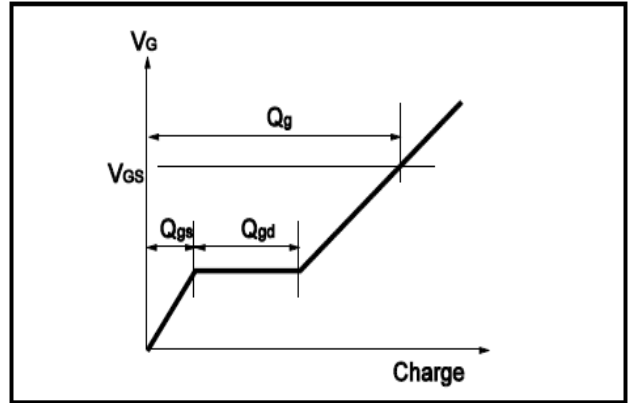


Fig.9 Switching Time Measurement Circuit

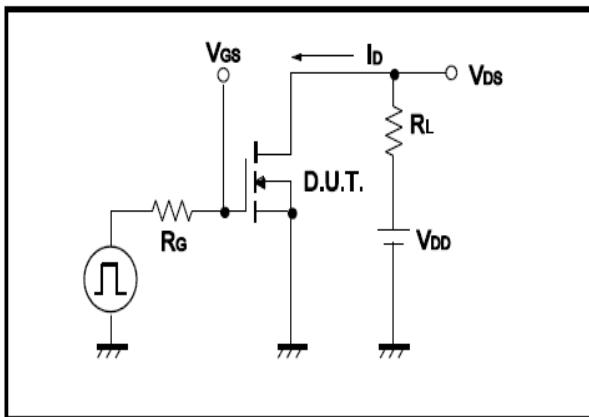


Fig.10 Gate Charge Waveform

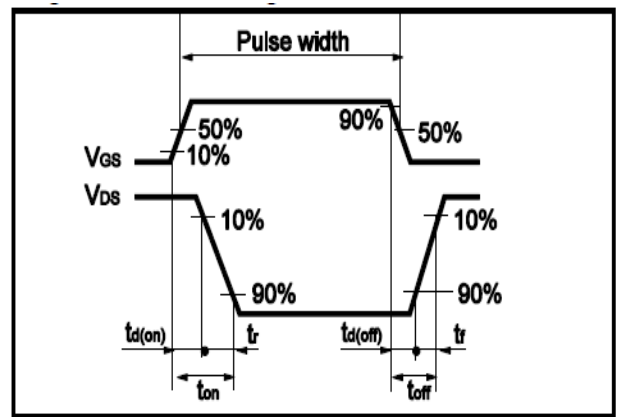


Fig.11 Avalanche Measurement Circuit

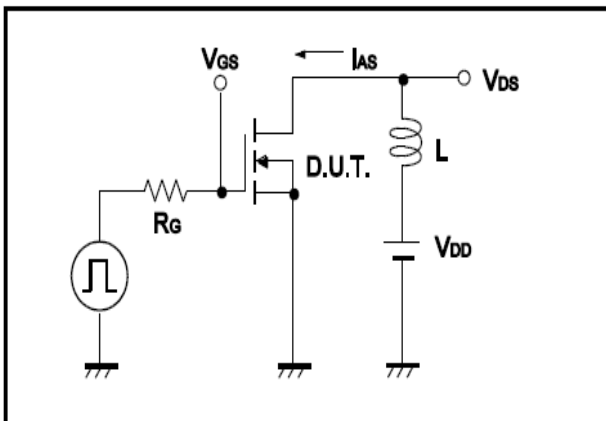
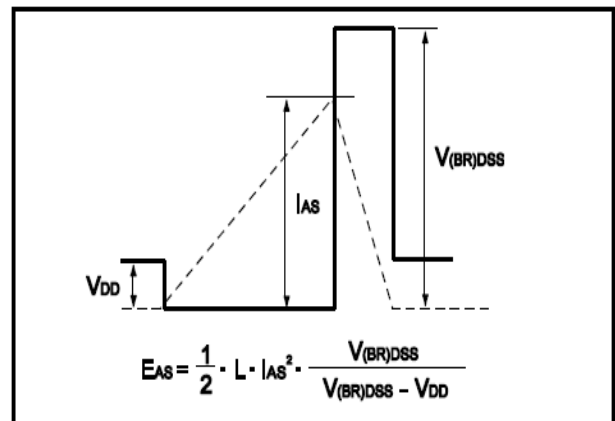
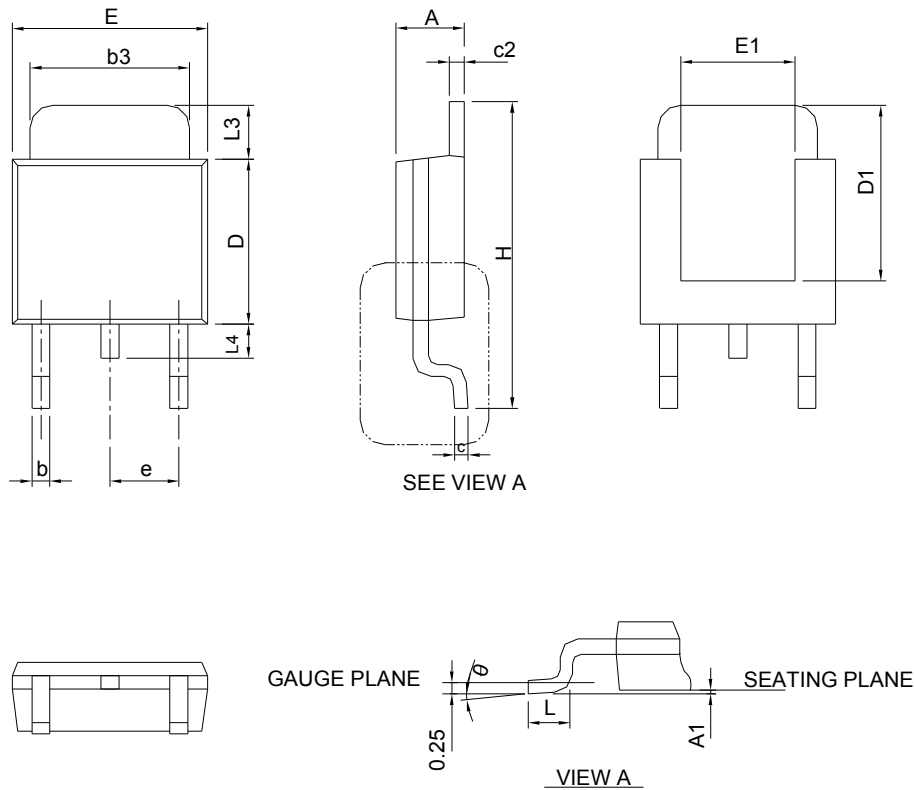


Fig.12 Avalanche Waveform



## Package Information

TO-252



DIMENSIONS	TO-252			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.39	0.086	0.094
A1		0.13		0.005
b	0.50	0.89	0.020	0.035
b3	4.95	5.46	0.195	0.215
c	0.46	0.61	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.33	6.22	0.210	0.245
D1	4.57	6.00	0.180	0.236
E	6.35	6.73	0.250	0.265
E1	3.81	6.00	0.150	0.236
e	2.29 BSC		0.090 BSC	
H	9.40	10.41	0.370	0.410
L	0.90	1.78	0.035	0.070
L3	0.89	2.03	0.035	0.080
L4		1.02		0.040
$\theta$	0°	8°	0°	8°

### RECOMMENDED LAND PATTERN

